

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination FUJIMURA, TSUTOMU	
		Examiner Patricia Leith	Art Unit 1655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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